

<b>Notice of References Cited</b>	Application/Control No. 10/711,002	Applicant(s)/Patent Under Reexamination SHEI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0052595	03-2003	Ellens et al.	313/501
*	B	US-2004/0095063	05-2004	Murazaki et al.	313/503
*	C	US-2004/0245532	12-2004	Maeda et al.	257/089
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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